International Conference on X-ray Optics and Microanalysis - ICXOM 23

Conference Agenda

Monday, Sept. 14

08:30 Registration
09:00 Welcome

Scanning Microscopy
09:30 Stefan Vogt, APS
10:30 David Paterson, AS

12:10 Lunch break

Micro / Nano Probes	Data Analysis
13:30 Alessandra Gianoncelli, ELETTRA	13:30 Doga Gursoy, APS

15:10 Coffee break

Nanoprobe Instrumentation	Microdiffration
16:10 Evgeny Nazaretski, NSLS-II	16:10 Veijo Honkimaeki, ESRF

17:15 Poster session and Welcoming Reception

19:00 End of Day 1

Tuesday, Sept. 15

X-ray Optics I
08:30 Kazuto Yamauchi, Osaka Univ.
09:30 Christian Schroer, Dresden Univ.

10:30 Coffee break

12:10 Lunch break

Zone Plates	Detectors
13:30 Stefan Rehbein, BESSY-II	13:30 C. Fiorini, P. d. Milano

15:10 Coffee break

Mirrors	Detectors
15:40 Ray Barrett, ESRF	15:40 Martin Radtke, BAM Berlin

17:20 Poster session (If there are more posters)

19:00 End of Day 2

Wednesday, Sept. 16

Ptychography and CDI I
08:30 David Shapiro, ALS
09:30 Sebastien Boutet, SLAC

10:30 Depart for Tours
11:00 Guided Tours

12:00 Lunch

Instrumentation
14:00 Qun Shen
15:00

15:40 Coffee break

Ptychography and CDI II

17:10 Poster Session (if there are more posters)

19:00 End of Day 3

Thursday, Sept. 17

Electron Microscopy
08:30 Judy Yang, Pittsburgh Univ.
09:30 Jianwei Miao, UC Los Angeles

10:10 Coffee break

12:10 Lunch break

Electron Microscopy	13:30 Full-field imaging
13:30 Invited talk	13:30 Yeukuang Hwu, TPS

15:10 Coffee break

PEEM	Full-field imaging
15:30 Andreas Scholl, ALS	15:30 Hendrik Kuepper, Bohemia Univ.

17:30 Start boarding buses for Banquet
18:00 Buses leave for Banquet
18:30 *Banquet*

22:00 End of Day 4

Friday, Sept. 18

X-Ray Optics II
08:30 Mourad Idir, NSLS-I
09:10 Kenneth Evans-Lutterodt, NSLS-II

10:10 Coffee break

11:50 *Close out*

Session title
Keynote lecture
Invited talk
Contributed talk
Breaks
General event